## Low Jitter and Skew 10 to 140 MHz Zero Delay Buffer (ZDB)

## Key Features

- 10 to 140 MHz operating frequency range
- Low output clock jitter
- 140 ps-max cycle-to-cycle jitter
- Low output-to-output skew: 150 ps-max
- Low product-to-product skew: 400 ps-max
- 3.3 V power supply range
- Low power dissipation:
- $26 \mathrm{~mA}-m a x$ at 66 MHz
- 44 mA -max at 133 MHz
- One input drives 9 outputs organized as $4+4+1$
- Select mode to bypass PLL or tri-state outputs
- SpreadThru ${ }^{\text {TM }}$ PLL that allows use of SSCG
- Standard and High-Drive options
- Available in 16-pin SOIC and TSSOP packages
- Available in Commercial and Industrial grades


## Applications

- Printers and MFPs
- Digital Copiers
- PCs and Work Stations
- DTV
- Routers, Switchers and Servers
- Digital Embeded Systems


## Description

The SL2309 is a low skew, low jitter and low power Zero Delay Buffer (ZDB) designed to produce up to nine (9) clock outputs from one (1) reference input clock, for high speed clock distribution applications.

The product has an on-chip PLL which locks to the input clock at CLKIN and receives its feedback internally from the CLKOUT pin

The SL2309 has two (2) clock driver banks each with four (4) clock outputs. These outputs are controlled by two (2) select input pins S1 and S2. When only four (4) outputs are needed, four (4) bank-B output clock buffers can be tristated to reduce power dissipation and jitter. The select inputs can also be used to tri-state both banks A and B or drive them directly from the input bypassing the PLL and making the product behave like a Non-Zero Delay Fanout Buffer (NZDB).

The high-drive $(-1 \mathrm{H})$ version operates up to 140 MHz and low drive (-1) version operates up to 100 MHz at 3.3 V .

## Benefits

- Up to nine (9) distribution of input clock
- Standard and High-Drive levels to control impedance level, frequency range and EMI
- Low power dissipation, jitter and skew
- Low cost


## Block Diagram



## Pin Configuration



16-Pin SOIC and TSSOP

## Pin Description

| Pin <br> Number | Pin Name | Pin Type |  |
| :---: | :--- | :---: | :--- |
| 1 | CLKIN | Input | Reference Frequency Clock Input. Weak pull-down (250k 2$).$ |
| 2 | CLKA1 | Output | Buffered Clock Output, Bank A. Weak pull-down (250k $\Omega)$. |
| 3 | CLKA2 | Output | Buffered Clock Output, Bank A. Weak pull-down $(250 \mathrm{k} \Omega)$. |
| 4 | VDD | Power | 3.3V Power Supply. |
| 5 | GND | Power | Power Ground. |
| 6 | CLKB1 | Output | Buffered Clock Output, Bank B. Weak pull-down (250k $\Omega)$. |
| 7 | CLKB2 | Output | Buffered Clock Output, Bank B. Weak pull-down $(250 \mathrm{k} \Omega)$. |
| 8 | S2 | Input | Select Input, select pin S2. Weak pull-up (250k $\Omega)$. |
| 9 | S1 | Input | Select Input, select pin S1. Weak pull-up (250k $\Omega)$. |
| 10 | CLKB3 | Output | Buffered Clock Output, Bank B. Weak pull-down $(250 \mathrm{k} \Omega)$. |
| 11 | CLKB4 | Output | Buffered Clock Output, Bank B. Weak pull-down (250k $\Omega)$. |
| 12 | GND | Power | Power Ground. |
| 13 | VDD | Power | 3.3V Power Supply. |
| 14 | CLKA3 | Output | Buffered Clock Output, Bank A. Weak pull-down $(250 \mathrm{k} \Omega)$. |
| 15 | CLKA4 | Output | Buffered Clock Output, Bank A. Weak pull-down (250k $\Omega)$. |
| 16 | CLKOUT | Output | Buffered Clock Output, PLL Internal Feedback Output. Weak pull-down (250k $\Omega)$. |

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## General Description

The SL2309 is a low skew, low jitter Zero Delay Buffer with very low operating current.

The product includes an on-chip high performance PLL that locks into the input reference clock and produces nine (9) output clock drivers tracking the input reference clock for systems requiring clock distribution.
In addition to CLKOUT that is used for internal PLL feedback, there are two (2) banks with four (4) outputs in each bank, bringing the number of total available output clocks to nine (9).

## Input and Output Frequency Range

The input and output frequency range is the same. But, it depends on the drive and output load (CL) levels as given in the below Table 1.

| Drive | CL(pF) | $\operatorname{Min}(M H z)$ | $\operatorname{Max}(M H z)$ |
| :---: | :---: | :---: | :---: |
| HIGH | 15 | 10 | 140 |
| HIGH | 30 | 10 | 100 |
| LOW | 15 | 10 | 100 |
| LOW | 30 | 10 | 66 |

Table 1. Input/Output Frequency Range
If the input clock is DC (GND to VDD) or floating, this is detected by an input frequency detection circuitry and all nine (9) clock outputs are forced to Hi-Z. The PLL is shutdown to save power. In this shutdown state, the product draws less than $12 \mu \mathrm{~A}$-max supply current.
In PLL by-pass mode ( $\mathrm{S} 2=1$ and $\mathrm{S} 1=0$ ), the detection circuit is disabled and input frequency range is 10 to 100 MHz for standard $(-1)$ drive and 10 to 140 MHz for high (-1H) drive.

## SpreadThru ${ }^{\text {TM }}$ Feature

If a Spread Spectrum Clock (SSC) were to be used as an input clock, the SL2309 is designed to pass the modulated Spread Spectrum Clock (SSC) signal from its reference input to the output clocks. The same spread characteristics at the input are passed through the PLL and drivers without any degradation in spread percent (\%), spread profile and modulation frequency

## Select Input Control (S2, S1)

The SL2309 provides two (2) input select control pins called S1 (Pin-9) and S2 (Pin-8). This feature enables users to select various states of output clock banks-A and bank-B, output source and PLL shutdown features as shown in the Table 2.
The S1 (Pin-9) and S2 (Pin-8) inputs include $250 \mathrm{k} \Omega$ weak pull-up resistors to VDD.

## PLL Bypass Mode

If the S1 and S2 pins are logic Low(0) and $\operatorname{High}(1)$ respectively, the on-chip PLL is shutdown and bypassed, and all the nine output clocks; bank A, bank B and CLKOUT clocks are driven by directly from the reference input clock. In this operation mode SL2309 works like a non-ZDB fanout buffer. In this operation mode the input power-down detection circuit is disabled and outputs follow the input clock from DC to rated frequencies based on drive levels and load specifications.

## High and Low-Drive Product Options

The SL2309 is offered with High Drive "-1H" and Standard Drive "-1" options. These drive options enable the users to control load levels, frequency range and EMI. Refer to the switching electrical tables for the details.

## Skew and Zero Delay

All outputs should drive the similar load to achieve the output-to-output skew and input-to-output specifications given in the switching electrical tables. However, Zero Delay between input and outputs can be adjusted by changing the loading at CLKOUT relative to the banks $A$ and $B$ clocks since CLKOUT is the feedback to the PLL.

## Power Supply Range (VDD)

The SL2309 is designed to operate at VDD=3.3V (+/$10 \%$ ). An internal on-chip voltage regulator is used to provide PLL constant power supply of 1.8 V , leading to a consistent and stable PLL electrical performance in terms of skew, jitter and power dissipation.

## SL23EP09

Refer to SL23EP09 for extended frequency operation from 10 to 220 MHz and 2.5 V to 3.3 V power supply operation range.

| S2 | S1 | Clock A1-A4 | Clock B1-4 | CLKOUT | Output Source | PLL Status |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | Tri-state | Tri-state | Driven | PLL | On |
| 0 | 1 | Driven | Tri-state | Driven | PLL | On |
| 1 | 0 | Driven | Driven | Driven | Reference | Off |
| 1 | 1 | Driven | Driven | Driven | PLL | On |

Table 2. Select Input Decoding


Figure 1. CLKIN Input to CLK A and B Delay (In terms of load difference between CLKOUT and CLK A and B)

## Absolute Maximum Ratings

| Description | Condition | Min | Max | Unit |
| :--- | :--- | :---: | :---: | :---: |
| Supply voltage, VDD |  | -0.5 | 4.6 | V |
| All Inputs and Outputs |  | -0.5 | VDD+0.5 | V |
| Ambient Operating Temperature | In operation, C-Grade | 0 | 70 | ${ }^{\circ} \mathrm{C}$ |
| Ambient Operating Temperature | In operation, I-Grade | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature | No power is applied | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |
| Junction Temperature | In operation, power is applied | - | 125 | ${ }^{\circ} \mathrm{C}$ |
| Soldering Temperature |  | - | 260 | ${ }^{\circ} \mathrm{C}$ |
| ESD Rating (Human Body Model) | JEDEC22-A114D | $-4,000$ | 4,000 | V |
| ESD Rating (Charge Device Model) | JEDEC22-C101C | $-1,500$ | 1,500 | V |
| ESD Rating (Machine Model) | JEDEC22-A115D | -250 | 250 | V |
| Latch-up | $125^{\circ} \mathrm{C}$ | -200 | 200 | mA |

Operating Conditions: Unless otherwise stated VDD $=3.3 \mathrm{~V}+/-10 \%$ and both C and I Grades

| Symbol | Description | Condition | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| VDD | 3.3V Supply Voltage | 3.3V+/-10\% | 3.0 | 3.6 | V |
| TA | Operating Temperature(Ambient) | Commercial | 0 | 70 | ${ }^{\circ} \mathrm{C}$ |
|  |  | Industrial | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |
| CLOAD | Load Capacitance | 10 to $140 \mathrm{MHz},-1 \mathrm{H}$ high drive All active PLL modes | - | 15 | pF |
|  |  | 10 to $100 \mathrm{MHz},-1 \mathrm{H}$ high drive All active PLL modes | - | 30 | pF |
|  |  | 10 to $100 \mathrm{MHz},-1$ standard drive All active PLL modes | - | 15 | pF |
|  |  | 10 to $66 \mathrm{MHz},-1$ standard drive All active PLL modes | - | 30 | pF |
| CIN | Input Capacitance | S1, S2 and CLKIN pins | - | 7 | pF |
| tpu | Power-up Time | Power-up time for all VDDs to reach minimum VDD voltage (VDD=3.0V). | 0.05 | 100 | ms |
| CLBW | Closed-loop bandwidth | 3.3V, (typical) | 1.2 |  | MHz |
| ZOUT | Output Impedance | 3.3 V , (typical), -1H high drive | 22 |  | $\Omega$ |
|  |  | 3.3V, (typical), -1 standard drive | 32 |  | $\Omega$ |

DC Electrical Specifications: Unless otherwise stated VDD $=3.3 \mathrm{~V}+/-10 \%$ and both C and I Grades

| Symbol | Description | Condition | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| VDD | Supply Voltage |  | 3.0 | 3.6 | V |
| VIL | Input LOW Voltage | CLKIN, S2 and S1 Pins | - | 0.8 | V |
| VIH | Input HIGH Voltage | CLKIN, S2 and S1 pins | 2.0 | VdD+0.3 | V |
| IIL | Input LOW Current | CLKIN, S2 and S1 Pins, $0<\mathrm{VIN}<0.8 \mathrm{~V}$ | - | 25 | $\mu \mathrm{A}$ |
| IIH | Input HIGH Current | CLKIN, S2 and S1 Pins, VIN = VDD | - | 50 | $\mu \mathrm{A}$ |
| VOL | Output LOW Voltage (All outputs) | $\mathrm{IOL}=8 \mathrm{~mA}$ (standard drive) | - | 0.4 | V |
|  |  | $\mathrm{IOL}=12 \mathrm{~mA}$ (high drive) | - | 0.4 | V |
| VOH | Output HIGH Voltage <br> (All outputs) | $\mathrm{IOH}=-8 \mathrm{~mA}$ (standard drive) | 2.4 | - | V |
|  |  | $\mathrm{IOH}=-12 \mathrm{~mA}$ (high drive) | 2.4 | - | V |
| IDDPD | Power Down Supply Current CLKIN=0 to VDD or floating (input will be pulled-down by $250 \mathrm{k} \Omega$ weak pull-down on-chip resistor) | C-Grade | - | 12 | $\mu \mathrm{A}$ |
|  |  | I-Grade | - | 25 | $\mu \mathrm{A}$ |
| IDD1 | Power Supply Current | All Outputs CL=0, 33MHz CLKIN S2=S1=1 (High) | - | 14 | mA |
| IDD2 | Power Supply Current | All Outputs CL=0, 66MHz CLKIN S2=S1=1 (High) | - | 26 | mA |
| IDD3 | Power Supply Current | All Outputs CL=0, 100MHz CLKIN S2=S1=1 (High) | - | 36 | mA |
| IDD4 | Power Supply Current | All Outputs CL=0, 133MHz CLKIN S2=S1=1 (High) | - | 44 | mA |
| RPU/D | Pull-up and Pull-down Resistors | Pins-1/2/3/6/7/8/9/10/11/14/15/16 $250 \mathrm{k} \Omega$-typ | 175 | 325 | $\mathrm{k} \Omega$ |

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Switching Specifications: Unless otherwise stated VDD $=3.3 \mathrm{~V}+/-10 \%$ and both C and I Grades

| Symbol | Description | Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| FMAX1 | Maximum Frequency ${ }^{[1]}$ (Input=Output ) <br> All Active PLL Modes | High drive (-1H). All outputs CL=15pF | 10 | - | 140 | MHz |
|  |  | High drive ( -1 H ), All outputs $\mathrm{CL}=30 \mathrm{pF}$ | 10 | - | 100 | MHz |
|  |  | Standard drive, (-1), All outputs CL=15pf | 10 | - | 100 | MHz |
|  |  | Standard drive, (-1), All outputs CL=30pf | 10 | - | 66 | MHz |
| FMAX2 | Maximum Frequency ${ }^{[1]}$ (Input=Output ) PLL Bypass Mode (S2=1 and S1=0) | High drive (-1H). All outputs CL=15pF | 0 | - | 140 | MHz |
|  |  | High drive (-1H), All outputs CL=30pF | 0 | - | 100 | MHz |
|  |  | Standard drive, (-1), All outputs CL=15pf | 0 | - | 100 | MHz |
|  |  | Standard drive, (-1), All outputs CL=30pf | 0 | - | 66 | MHz |
| INDC | Input Duty Cycle | Measured at 1.4 V , Fout $=66 \mathrm{MHz}, \mathrm{CL}=15 \mathrm{pF}$ | 30 | 50 | 70 | \% |
| OUTDC1 | Output Duty Cycle ${ }^{[2]}$ | Measured at 1.4 V , Fout $=66 \mathrm{MHz}, \mathrm{CL}=15 \mathrm{pF}$ | 40 | 50 | 60 | \% |
| OUTDC2 | Output Duty Cycle ${ }^{[2]}$ | Measured at 1.4 V , Fout $=66 \mathrm{MHz}, \mathrm{CL}=15 \mathrm{pF}$ | 40 | 50 | 60 | \% |
| tr/f | Rise, Fall Time (3.3V) ${ }^{[2]}$ (Measured at: 0.8 to 2.0 V ) | High drive ( -1 H ), CL=15pF | - | - | 1.5 | ns |
|  |  | High drive ( -1 H ), CL=30pF | - | - | 1.8 | ns |
|  |  | Standard drive (-1), CL=15pF | - | - | 2.2 | ns |
|  |  | Standard drive (-1), CL=30pF | - | - | 2.5 | ns |
| t1 | Output-to-Output Skew ${ }^{[2]}$ (Measured at VDD/2) | All outputs CL=0 or equally loaded, -1 or -1H drives | - | 70 | 150 | ps |
| t2 | Product-to-Product Skew ${ }^{[2]}$ (Measured at VDD/2) | All outputs $C L=0$ or equally loaded, -1 or -1H drives | - | 180 | 400 | ps |
| t3 | Delay Time, CLKIN Rising Edge to CLKOUT Rising Edge ${ }^{[2]}$ <br> (Measured at VDD/2) | PLL Bypass mode Only when S2=1 and S1=0 | 1.5 | 5 | 8.7 | ns |
|  |  | PLL enabled <br> All active PLL modes | -220 | - | 220 | ps |
| tPLOCK | PLL Lock Time ${ }^{[2]}$ | Time from 90\% of VDD to valid clocks on all the output clocks | - | - | 1.0 | ms |
| CCJ | Cycle-to-cycle Jitter ${ }^{[2]}$ | Fin=Fout=66 MHz, <CL=15pF, -1H drive | - | 70 | 140 | ps |
|  |  | Fin=Fout=66 MHz, <CL=15pF, -1 drive | - | 75 | 150 | ps |
|  |  | Fin=Fout=66 MHz, <CL=30pF, -1 H drive | - | 80 | 160 | ps |
|  |  | Fin=Fout=66 MHz, <CL=30pF, -1 drive | - | 85 | 170 | ps |

## Notes:

1. For the given maximum loading conditions. See CL in Operating Conditions Table.
2. Parameter is guaranteed by design and characterization. Not $100 \%$ tested in production.

## External Components \& Design Considerations

## Typical Application Schematic



## Comments and Recommendations

Decoupling Capacitor: A decoupling capacitor of $0.1 \mu \mathrm{~F}$ must be used between VDD and VSS pins. Place the capacitor s on the component side of the PCB as close to the VDD pins as possible. The PCB trace to the VDD pin and to the GND via should be kept as short as possible. Do not use vias between the decoupling capacitor and the VDD pin.
Series Termination Resistor: A series termination resistor is recommended if the distance between the output clocks and the load is over $11 / 2$ inch. The nominal impedance of the clock outputs is given on the page 4 . Place the series termination resistors as close to the clock outputs as possible.

Zero Delay and Skew Control: All outputs and CLKIN pins should be loaded with the same load to achieve "Zero Delay" between the CLKIN and the outputs. The CLKOUT pin is connected to CLKIN internally on-chip for feedback to PLL, and sees an additional 2 pF load with respect to Bank A and B clocks. For applications requiring zero input/output delay, the load at the all output pins including the CLKOUT pin must be the same. If any delay adjustment is required, the capacitance at the CLKOUT pin could be increased or decreased to increase or decrease the delay between Bank A and B clocks and CLKIN.

For minimum pin-to-pin skew, the external load at all the Bank A and B clocks must be the same.

## Switching Waveforms



Figure 2. Output to Output Skew


Figure 3. Input-to-Output Skew


Figure 4. Part-to-Part Skew

## Package Drawing and Dimensions

## 16-Lead TSSOP (4.4-mm)




## Thermal Characteristics

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Thermal Resistance Junction to Ambient | $\theta$ JA | Still air | - | 80 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  | $\theta \mathrm{JA}$ | 1m/s air flow | - | 70 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  | $\theta \mathrm{JA}$ | $3 \mathrm{~m} / \mathrm{s}$ air flow | - | 68 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Thermal Resistance Junction to Case | $\theta$ JC | Independent of air flow | - | 36 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

## Package Drawing and Dimensions (Cont.)

## 16-Lead SOIC (150-Mil)




## Thermal Characteristics

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Thermal Resistance Junction to Ambient | $\theta \mathrm{JA}$ | Still air | - | 120 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  | $\theta \mathrm{JA}$ | 1m/s air flow | - | 115 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  | $\theta \mathrm{JA}$ | $3 \mathrm{~m} / \mathrm{s}$ air flow | - | 105 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Thermal Resistance Junction to Case | $\theta$ JC | Independent of air flow | - | 60 | - | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

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## Ordering Information ${ }^{[3]}$

| Ordering Number | Marking | Shipping Package | Package | Temperature |
| :---: | :---: | :---: | :---: | :---: |
| SL2309ZC-1 | SL2309ZC-1 | Tube | 16 -pin TSSOP | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309ZC-1T | SL2309ZC-1 | Tape and Reel | 16 -pin TSSOP | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309ZC-1H | SL2309ZC-1H | Tube | 16 -pin TSSOP | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309ZC-1HT | SL2309ZC-1H | Tape and Reel | 16 -pin TSSOP | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309ZI-1 | SL2309ZI-1 | Tube | 16 -pin TSSOP | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309ZI-1T | SL2309ZI-1 | Tape and Reel | 16 -pin TSSOP | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309ZI-1H | SL2309ZI-1H | Tube | 16 -pin TSSOP | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309ZI-1HT | SL2309ZI-1H | Tape and Reel | 16 -pin TSSOP | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309SC-1 | SL2309SC-1 | Tube | 16 -pin SOIC | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309SC-1T | SL2309SC-1 | Tape and Reel | 16 -pin SOIC | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309SC-1H | SL2309SC-1H | Tube | 16 -pin SOIC | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309SC-1HT | SL2309SC-1H | Tape and Reel | 16 -pin SOIC | 0 to $70^{\circ} \mathrm{C}$ |
| SL2309SI-1 | SL2309SI-1 | Tube | 16 -pin SOIC | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309SI-1T | SL2309SI-1 | Tape and Reel | 16 -pin SOIC | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309SI-1H | SL2309SI-1H | Tube | 16 -pin SOIC | -40 to $85^{\circ} \mathrm{C}$ |
| SL2309SI-1HT | SL2309SI-1H | Tape and Reel | 16 -pin SOIC | -40 to $85^{\circ} \mathrm{C}$ |

## Notes:

3. The SL2309 products are RoHS compliant.

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